**REMARKS** 

Claims 1-4 and 6-9 are pending in this application. Claim 1 has been herein amended.

Reconsideration of the rejections in view of these amendments and the following remarks is

respectfully requested.

Rejections under 35 USC §112, Second Paragraph

Claims 1-4 and 6-9 are rejected under 35 USC §112, second paragraph, as being

indefinite.

Accordingly, the claims have been amended to overcome the rejection.

In the rejection, the Examiner noted that "the insulating film is only formed on the top of

the P-N junction." However, the P-type semiconductor region and the N-type semiconductor

region of the P-N junction of said gate electrode are electrically insulated on all sides of the P-N

junction. As shown in Fig. 3, the P-type semiconductor region and the N-type semiconductor

region of the P-N junction are insulated at the bottom by the gate oxide film. The other sides are

also insulated by air. The insulation can be in any form.

Thus, the invention is not indefinite in the recitation "wherein said P-type semiconductor

region and said N-type semiconductor region of said P-N junction of said gate electrode are

electrically insulated on all sides of said P-N junction."

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## Rejections under 35 USC §103(a)

Claims 1 and 7 were rejected under 35 USC §103(a) as being obvious over <u>AAPA</u> (Applicant's admitted prior art) in view of <u>Pfiester</u> (U.S. Patent No. 4,745,079). Claims 2 and 3 were rejected under 35 USC §103(a) as being obvious over <u>AAPA</u> in view of <u>Pfiester</u> further in view of <u>Kakumu</u> (U.S. Patent No. 5,466,958). Claim 6 was rejected under 35 USC §103(a) as being obvious over <u>AAPA</u> in view of <u>Pfiester</u> further in view of <u>Matloubian</u> (U.S. Patent No. 5,144,390). Claims 8 and 9 were rejected under 35 USC §103(a) as being obvious over <u>AAPA</u> in view of <u>Pfiester</u> and <u>Matloubian</u> and further in view of <u>Cherne et al</u> (U.S. Patent H1435).

Applicant respectfully traverses these rejections.

Admitting that AAPA does not show that "said P-type semiconductor region and said N-type semiconductor region of said P-N junction of said gate electrode are electrically insulated on all sides," the Examiner alleged that "Pfiester (figure 9) teaches the P-type semiconductor region and the N-type semiconductor region of P-N junction of the gate electrode are electrically insulated on all sides," and "it would have been obvious . . . to incorporate the teaching of Pfiester into the device taught by AAPA because it provides an insulator between the P-N junction and the external device."

In order to further clarify the present invention, claim 1 has been amended to recite, among other things, "a gate electrode provided on said gate insulating film and formed with a P-N junction including a P-type semiconductor region and an N-type semiconductor region, said P-N junction extending parallel to a source-drain direction of said source region and said drain region."

In Pfiester, as shown in Fig. 9, the P-N junctions extend perpendicular to the source drain

direction. Thus, Pfiester does not teach or suggest, among other things, "said P-N junction

extending parallel to a source-drain direction of said source region and said drain region," as

recited in amended claim 1.

For at least these reasons, claim 1 patentably distinguishes over <u>AAPA</u> and <u>Pfiester</u>.

Claims 2-9, depending from claim 1, also patentably distinguish over AAPA and Pfiester

for at least the same reason. Kakumu Matloubian and Cherne et al are cited for allegedly

disclosing the additional recitations in these dependent claims, but these cited reference do not

remedy the deficiencies of AAPA and Pfiester discussed above. Therefore, claim 2-9 patentably

distinguish over AAPA, Pfiester, Kakumu Matloubian and Cherne et al.

Thus, the 35 USC §103(a) rejections should be withdrawn.

It is submitted that nothing in the cited references, taken either alone or in combination,

teaches or suggests all the features recited in each claim of the present invention. Thus all pending

claims are in condition for allowance. Reconsideration of the rejections, withdrawal of the

rejections and an early issue of a Notice of Allowance are earnestly solicited.

If, for any reason, it is felt that this application is not now in condition for allowance, the

Examiner is requested to contact Applicant's undersigned attorney at the telephone number

indicated below to arrange for an interview to expedite the disposition of this case.

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Application No. 10/084,925 Amendment dated June 30, 2004 Reply to Office Action of March 3, 2004

In the event that this paper is not timely filed, Applicant respectfully petitions for an appropriate extension of time. The fees for such an extension or any other fees which may be due with respect to this paper, may be charged to Deposit Account No. 50-2866.

Respectfully submitted,

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